


<b>Search Notes</b>  	<b>Application/Control No.</b>  10670057	<b>Applicant(s)/Patent Under Reexamination</b>  AHN ET AL.
	<b>Examiner</b>  Han, Jason M	<b>Art Unit</b>  2875

SEARCHED			
Class	Subclass	Date	Examiner
362	231, 252, 349, 555, 612, 800	1/17/2007	JMH
349	68-69	1/17/2007	JMH

SEARCH NOTES		
Search Notes	Date	Examiner
Search Update - EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT) - See Printout	1/17/2007	JMH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	EAST (US-PGPUB) - See Printout	1/17/2007	JMH